


<b>Search Notes</b>  	<b>Application/Control No.</b>  10661047	<b>Applicant(s)/Patent Under Reexamination</b>  RISAN ET AL.
	<b>Examiner</b>  JASON K GEE	<b>Art Unit</b>  2434

SEARCHED			
Class	Subclass	Date	Examiner
713	164	4/7/2009	JKG
726	6	4/7/2009	JKG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST - US_PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	4/7/2009	JKG
PALM - Inventor Name Search	4/7/2009	JKG
Google Scholar - DRM	4/7/2009	JKG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
713	165164	4/7/2009	JKG

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